FMOS2304-Q1-H

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3.3A 30V N-Channel Enhancement Mode Trench MOSFET

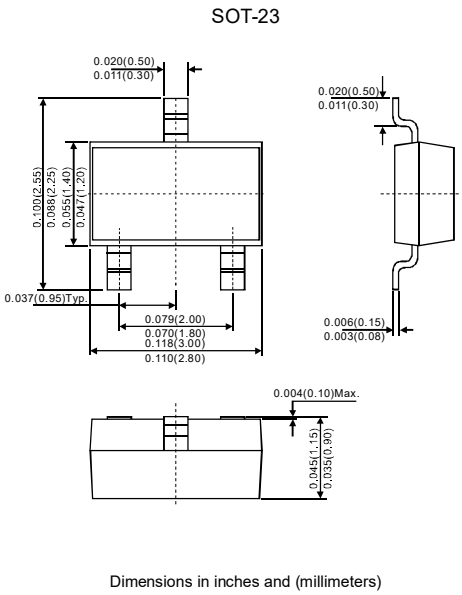
Features

- TrenchFET power MOSFET.
- Load switch for portable devices.
- Qualified to AEC-Q101 standards for high reliability.
- Lead-free parts meet RoHS requirements.
- Halogen-free (IEC61249-2-21) .

Mechanical data

- Epoxy:UL94-V0 rated flame retardant.
- Case : Molded plastic, SOT-23.
- Terminals : Solder plated, solderable per MIL-STD-750, Method 2026.
- Weight : Approximated 10mg.

Package outline



Dimensions in inches and (millimeters)

Maximum ratings (At T_A=25°C unless otherwise noted)

Parameter	Symbol	Ratings	Unit
Drain-source voltage	V_{DS}	30	V
Gate-source voltage	V_{GS}	±20	V
Continuous drain current	I_D	3.3	A
Pulsed drain current	I_{DM}	15	A
Continuous source-drain diode current	I_S	0.9	mA
Power dissipation	P_D	0.35	W
Thermal resistance, junction to ambient	$R_{\Theta JA}$	357	℃/W
Junction temperature	T_J	+150	℃
Storage temperature range	T_{STG}	-55 to +150	℃

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Electrical characteristics (At T_A=25°C unless otherwise noted)

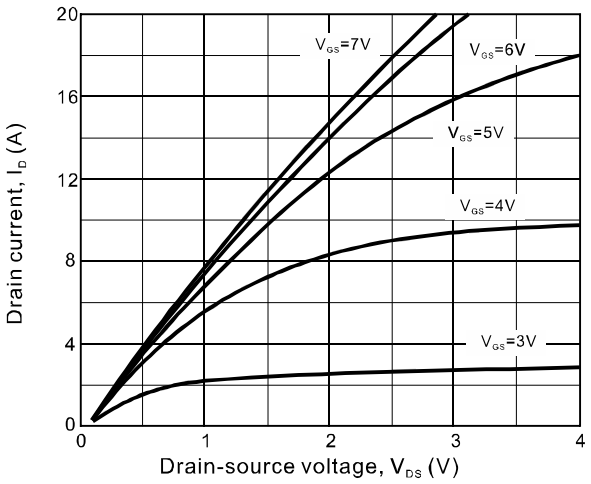
Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Off characteristics						
Drain-source breakdown voltage	BV_{DSS}	V_{GS} = 0V, I_D = 250μA	30			V
Drain-source leakage current	I_{DSS}	V_{DS} = 30V, V_{GS}=0V			1	μA
Gate-source leakage current	I_{GSS}	V_{DS} = 0V, V_{GS} = ±20V			±100	nA
On characteristics						
Gate threshold voltage	$V_{GS(TH)}$	V_{DS} = V_{GS}, I_D = 250μA	1.0	1.55	2.2	V
Forward trans conductance (Note1)	g_{FS}	V_{DS} = 4.5V, I_D = 2.5A	2.5			S
Static drain-source on-resistance (Note1)	$R_{DS(ON)}$	V_{GS} = 10V, I_D = 3.2A		37	60	mΩ
		V_{GS} = 4.5V, I_D = 2.8A		57	75	
Dynamic parameters						
Input capacitance (Note2)	C_{iss}	V_{GS} = 0V, V_{DS} = 15V, f = 1.0MHZ		235		pF
Out capacitance (Note2)	C_{oss}			45		
Reverse transfer capacitance (Note2)	C_{rss}			17		
Gate resistance	R_g	f = 1.0MHz	0.8	4.4	8.8	Ω
Switching parameters						
Turn-on delay time (Note2)	$t_{d(on)}$	V_{DD} = 15V, V_{GEN} = 4.5V, R_G=1 Ω, R_L = 5.6Ω, I_D ≈ 2.7A		12	20	ns
Rise time (Note2)	t_r			50	75	
Turn-off delay time (Note2)	$t_{d(off)}$			12	20	
Fall time (Note2)	t_f			22	35	
Turn-on delay time (Note2)	$t_{d(on)}$	V_{DD} = 15V, V_{GEN} = 10V, R_G = 1 Ω, R_L = 5.6Ω, I_D ≈ 2.7A		5	10	ns
Rise time (Note2)	t_r			12	20	
Turn-off delay time (Note2)	$t_{d(off)}$			10	15	
Fall time (Note2)	t_f			5	10	
Total gate charge	Q_g	V_{DS} = 15V, I_D = 3.4A, V_{GS} = 10V		4.5	6.7	nC
		V_{DS} = 15V, I_D = 3.4A, V_{GS} = 4.5V		2.1	3.2	
Gate source charge	Q_{gs}			0.85		
Gate drain charge	Q_{gd}			0.65		
Source-drain diode ratings and characteristics						
Maximum body-diode continuous current	I_S	T_C = 25ºC			1.4	A
Pulse diode forward current	I_{SM}				15	A
Diode forward voltage	V_{SD}	V_{GS} = 0V, I_S = 2.7A		0.8	1.2	V

Notes :1. Pulse test : pulse width ≤ 300μs, duty cycle ≤ 2%.
2. These parameters have no way to verify.

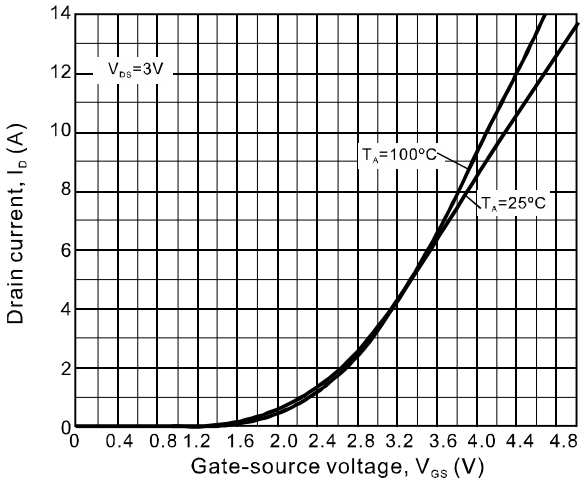
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Rating and characteristic curves

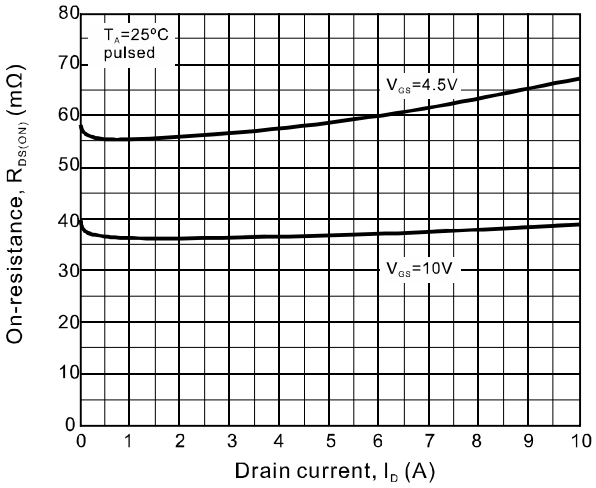
Output characteristics



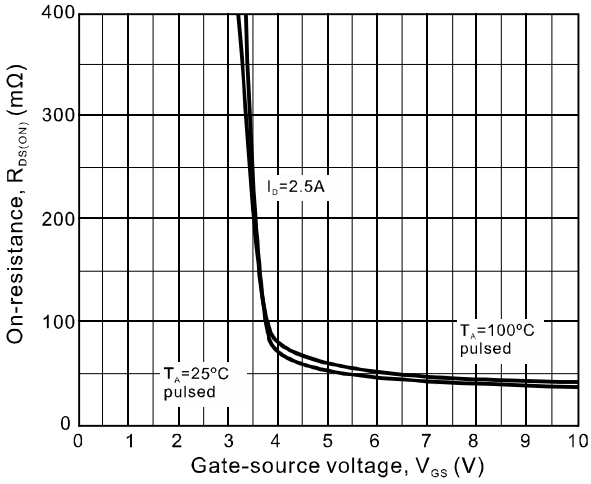
Transfer characteristics



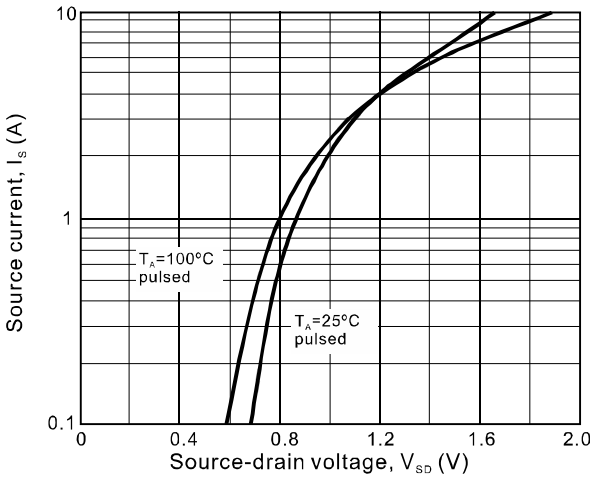
On-resistance vs. Drain current



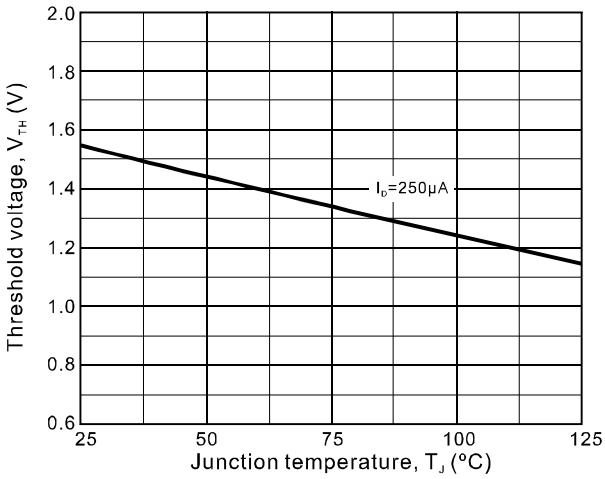
On-resistance vs. Gate-source voltage



Source current vs. Source-drain voltage

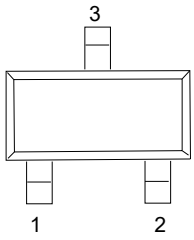
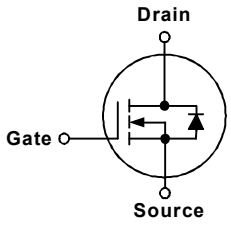


Treshold voltage



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Pinning information

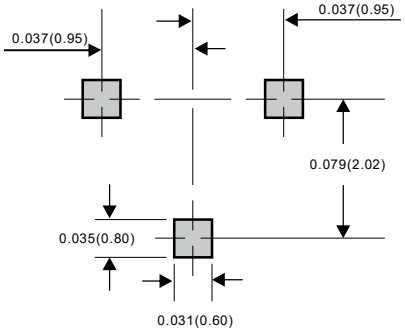
Pin	Simplified outline	Symbol
Pin 1 Gate Pin 2 Source Pin 3 Drain		

Marking

Type number	Marking code
FMOS2304-Q1-H	S4

Suggested solder pad layout

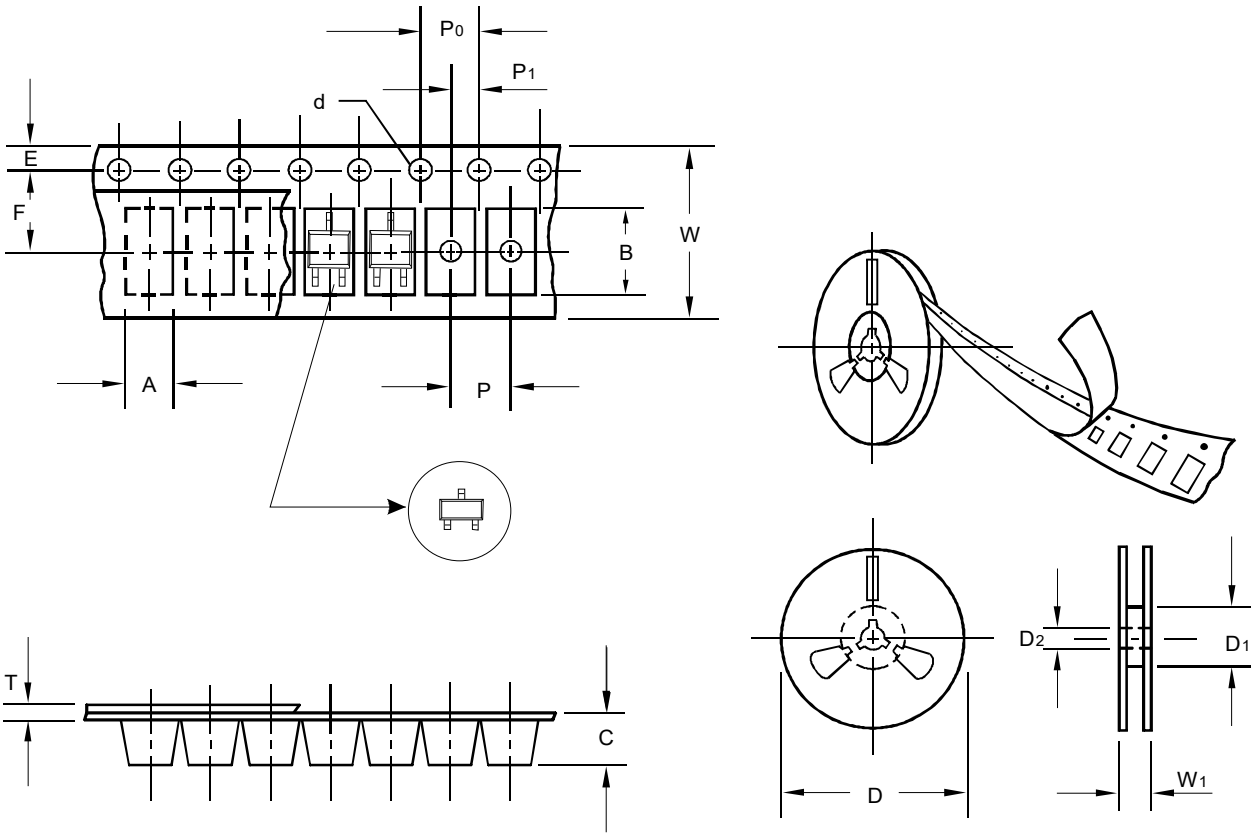
SOT-23



Dimensions in inches and (millimeters)

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Packing information



unit:mm

Item	Symbol	Tolerance	SOT-23
Carrier width	A	0.5	3.15
Carrier length	B	0.5	2.77
Carrier depth	C	0.5	1.22
Sprocket hole	d	0.5	1.50
13" Reel outside diameter	D	2.0	-
13" Reel inner diameter	D_1	min	-
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D_1	min	54.40
Feed hole diameter	D_2	0.5	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	4.00
Sprocket hole pitch	P_0	0.1	4.00
Embossment center	P_1	0.1	2.00
Overall tape thickness	T	0.1	0.23
Tape width	W	0.5	8.00
Reel width	W_1	5.0	12.30

Note:Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

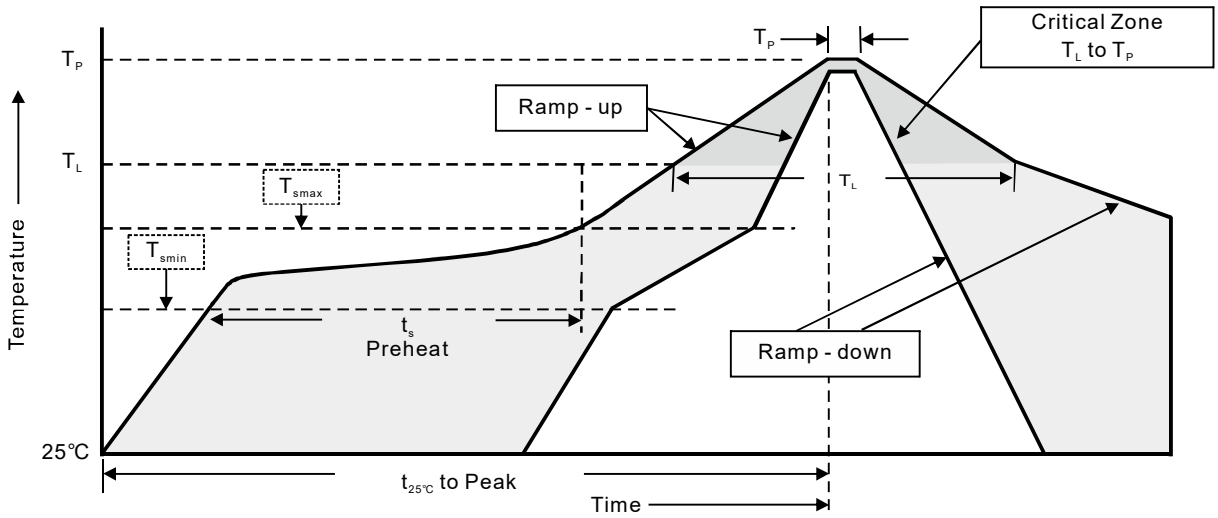
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Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (m/m)	BOX (pcs)	INNER BOX (m/m)	REEL DIA, (m/m)	CARTON SIZE (m/m)	CARTON (pcs)	APPROX. GROSS WEIGHT (kg)
SOT-23	7"	3,000	4.0	30,000	183*123*183	178	382*257*387	240,000	11.6

Suggested thermal profiles for soldering processes

1. Storage environment : Temperature = 5℃ ~ 40℃, Humidity = 55%, ±25%.
2. Reflow soldering of surface - Mount devices.



3. Reflow soldering

Profile feature	Soldering condition
Average ramp-up rate (T_L to T_P)	< 3 ℃/sec
Preheat - Temperature Min (T_{smin}) - Temperature Max (T_{smax}) - Time (Min to Max) (t_s)	 150℃ 200℃ 60 ~ 120 sec
T_{smax} to T_L - Ramp-up rate	 < 3 ℃ / sec
Time maintained above : - Temperature (T_L) - Time (T_L)	 217℃ 60 ~ 260 sec
Peak temperature (T_P)	255 ℃ -0 / +5℃
Time with 5℃ of actual peak temperature (T_P)	10 ~ 30 sec
Ramp-down rate	< 6℃ / sec
Time 25℃ to peak temperature	< 6 minutes